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## FAIRCHILD

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## FQA28N50F **500V N-Channel MOSFET**

### **General Description**

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switch mode power supplies, where the body diode is used such as phase-shift ZVS, basic full-bridge topology.

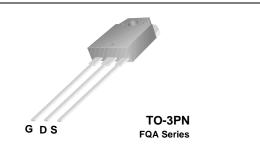
## September 2001

## **FRFET**<sup>™</sup>

FQA28N50F

### Features

- 28.4A, 500V,  $R_{DS(on)} = 0.16\Omega @V_{GS} = 10 V$  Low gate charge ( typical 110 nC)
- Low Crss (typical 60 pF) •
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability
- Fast recovery body diode (max, 250ns)



## Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter		FQA28N50F	Units
V <sub>DSS</sub>	Drain-Source Voltage		500	V
I <sub>D</sub>	Drain Current - Continuous ( $T_C = 25^{\circ}$	C)	28.4	A
	- Continuous (T <sub>C</sub> = 100	°C)	18	A
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	113.6	А
V <sub>GSS</sub>	Gate-Source Voltage		± 30	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy	(Note 2)	1300	mJ
I <sub>AR</sub>	Avalanche Current	(Note 1)	28.4	A
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	31	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	17	V/ns
PD	Power Dissipation (T <sub>C</sub> = 25°C)		310	W
	- Derate above 25°C		2.5	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C
ΤL	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

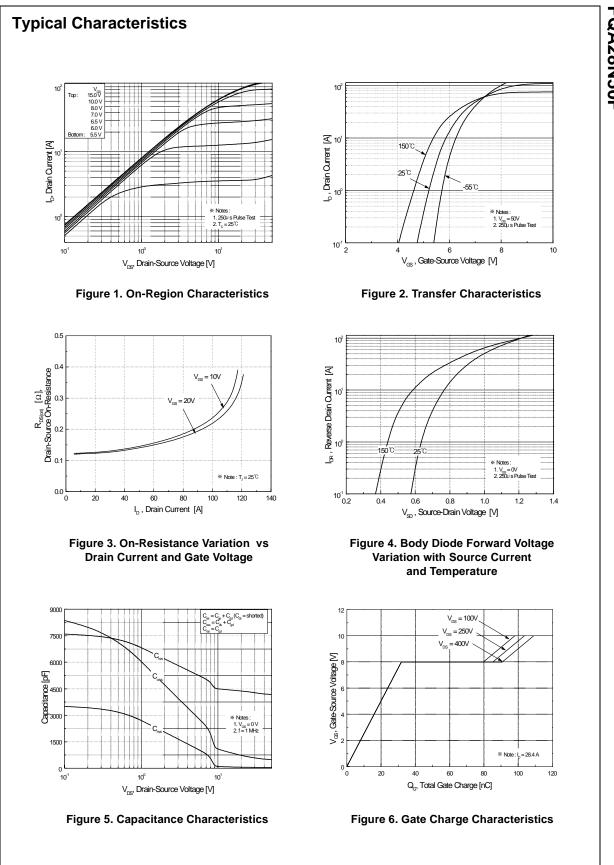
## **Thermal Characteristics**

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		0.4	°C/W
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink	0.24		°C/W
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction-to-Ambient		40	°C/W

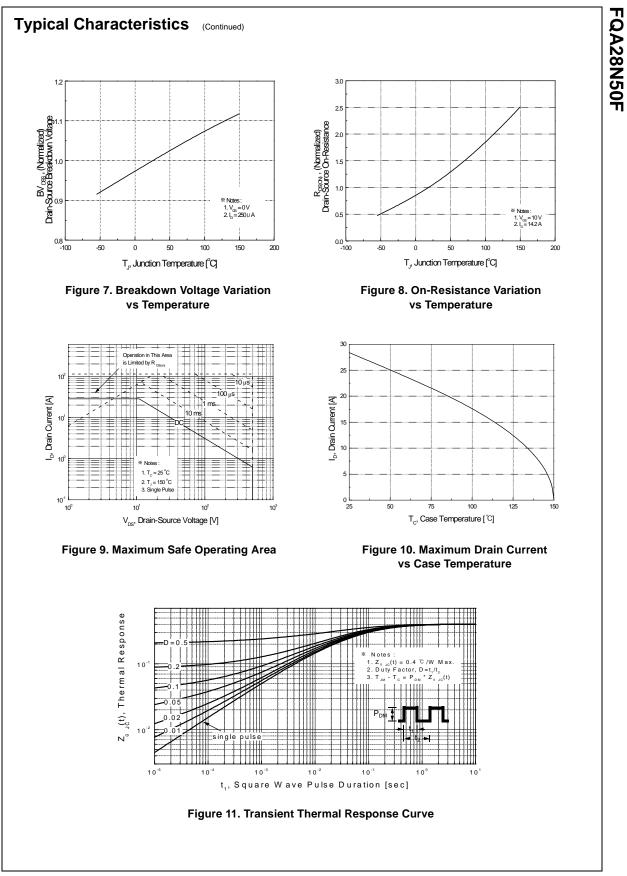
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Cha	aracteristics					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 V, I_{D} = 250 \mu A$	500			V
ΔBV <sub>DSS</sub> / ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu A$ , Referenced to 25	°C	0.5		V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 500 \text{ V}, V_{GS} = 0 \text{ V}$			50	μA
		V <sub>DS</sub> = 400 V, T <sub>C</sub> = 125°C			500	μA
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	$V_{GS} = 30 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	$V_{GS} = -30 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			-100	nA
On Cha	aracteristics					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	3.0		5.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 14.2 A		0.126	0.16	Ω
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 50 \text{ V}, I_D = 14.2 \text{ A}$ (Note	e 4)	28		S
C <sub>iss</sub>	ic Characteristics Input Capacitance	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V,		4300	5600	pF
		$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$				
C <sub>oss</sub> C <sub>rss</sub>	Output Capacitance	f = 1.0 MHz		640	830	pF
Orss	Reverse Transfer Capacitance			60	80	pF
Switch	ing Characteristics					
t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DD</sub> = 250 V, I <sub>D</sub> = 28.4 A,		100	210	ns
t <sub>r</sub>	Turn-On Rise Time	$R_{G} = 25 \Omega$		290	590	ns
t <sub>d(off)</sub>	Turn-Off Delay Time			250	510	ns
t <sub>f</sub>	Turn-Off Fall Time	(Note 4	4, 5)	175	360	ns
Qg	Total Gate Charge	V <sub>DS</sub> = 400 V, I <sub>D</sub> = 28.4 A,		110	140	nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> = 10 V		32		nC
Q <sub>gd</sub>	Gate-Drain Charge	(Note 4	4, 5)	59		nC
		- I Marcine Datio				
	Source Diode Characteristics and Maximum Ratings Maximum Continuous Drain-Source Diode Forward Current				28.4	А
IS	Maximum Pulsed Drain-Source Diode Forward Current				-	
-	Maximum Pulsed Drain-Source Diode F	Forward Current			113.6	A
I <sub>SM</sub>					113.6 1.4	A V
I <sub>S</sub> I <sub>SM</sub> V <sub>SD</sub> t <sub>rr</sub>	Maximum Pulsed Drain-Source Diode F Drain-Source Diode Forward Voltage Reverse Recovery Time	Forward Current $V_{GS} = 0 V, I_S = 28.4 A$ $V_{GS} = 0 V, I_S = 28.4 A,$			113.6 1.4 250	

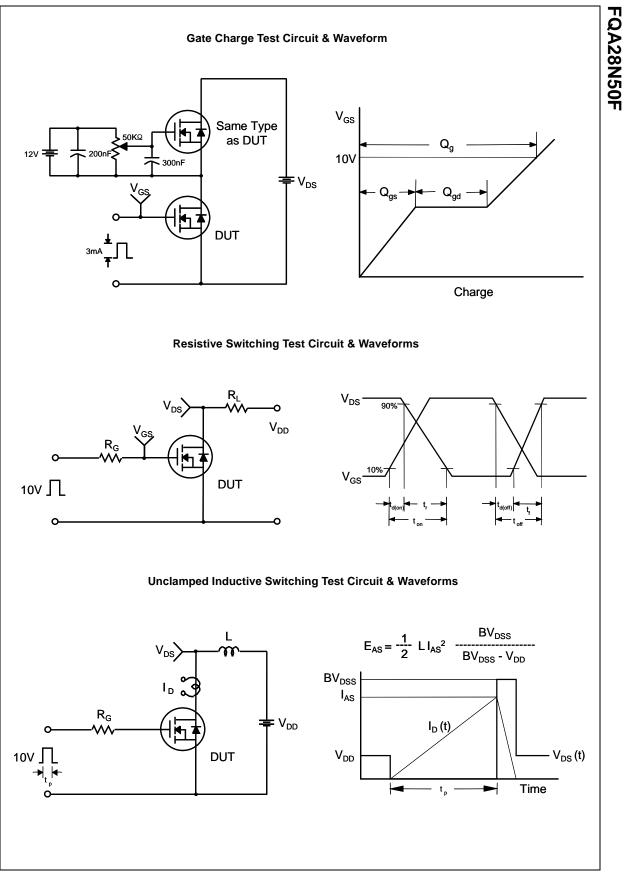
**Notes:** 1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 2.9mH, I<sub>AS</sub> = 28.4A, V<sub>DD</sub> = 50V, R<sub>G</sub> = 25  $\Omega$ , Starting T<sub>J</sub> = 25°C 3. I<sub>SD</sub>  $\leq$  28.4A, d/dt  $\leq$  350A/µs, V<sub>DD</sub>  $\leq$  BV<sub>DSS</sub>, Starting T<sub>J</sub> = 25°C 4. Pulse Test : Pulse width  $\leq$  300µs, Duty cycle  $\leq$  2% 5. Essentially independent of operating temperature

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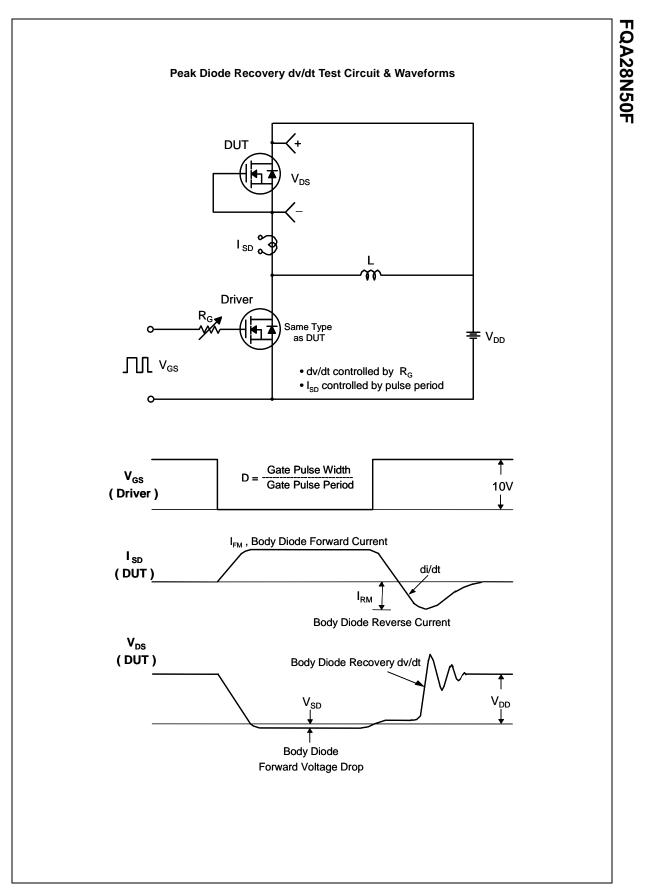


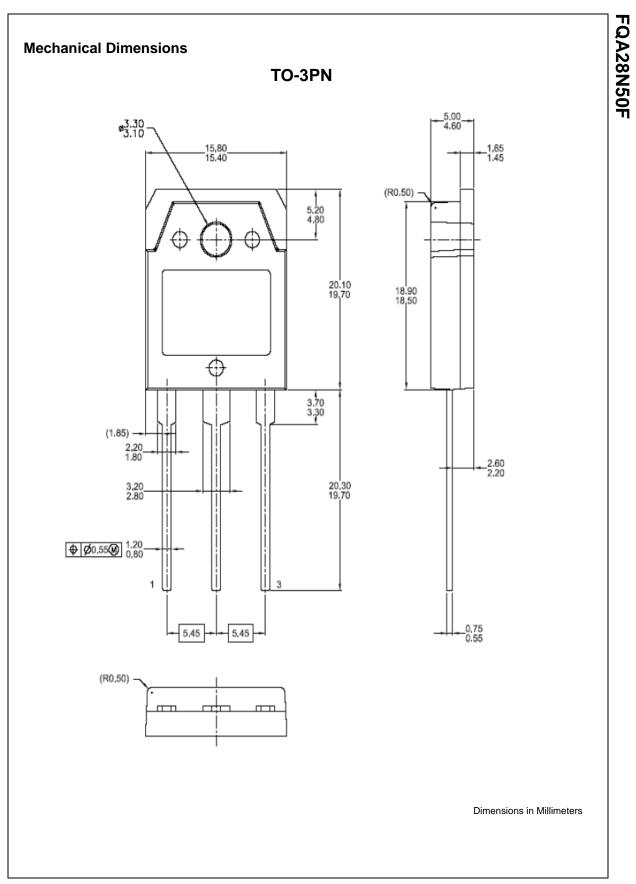
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